

# SN54ABT533, SN74ABT533A OCTAL TRANSPARENT D-TYPE LATCHES WITH 3-STATE OUTPUTS

SCBS186D – JANUARY 1991 – REVISED JANUARY 1997

- State-of-the-Art **EPIC-II<sup>™</sup>** BiCMOS Design Significantly Reduces Power Dissipation
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Typical  $V_{OLP}$  (Output Ground Bounce) < 1 V at  $V_{CC} = 5$  V,  $T_A = 25^\circ\text{C}$
- High-Drive Outputs ( $-32\text{-mA } I_{OH}$ ,  $64\text{-mA } I_{OL}$ )
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model ( $C = 200$  pF,  $R = 0$ )
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, Ceramic Chip Carriers (FK), Plastic (N) and Ceramic (J) DIPs, and Ceramic Flat (W) Package

## description

These octal transparent D-type latches with 3-state outputs are designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

When the latch-enable (LE) input is high, the  $\overline{Q}$  outputs follow the complements of the data (D) inputs. When LE is taken low, the  $\overline{Q}$  outputs are latched at the inverse of the levels at the D inputs.

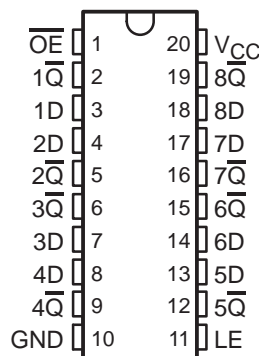
A buffered output-enable ( $\overline{OE}$ ) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without need for interface or pullup components.

$\overline{OE}$  does not affect the internal operations of the latches. Previously stored data can be retained or new data can be entered while the outputs are in the high-impedance state.

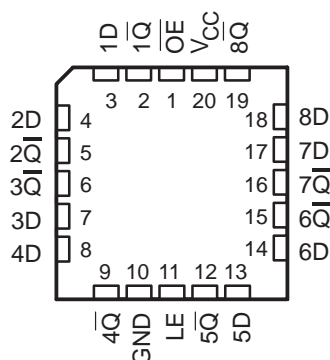
To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54ABT533 is characterized for operation over the full military temperature range of  $-55^\circ\text{C}$  to  $125^\circ\text{C}$ . The SN74ABT533A is characterized for operation from  $-40^\circ\text{C}$  to  $85^\circ\text{C}$ .

SN54ABT533 . . . J OR W PACKAGE  
SN74ABT533A . . . DB, DW, N, OR PW PACKAGE  
(TOP VIEW)



SN54ABT533 . . . FK PACKAGE  
(TOP VIEW)



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**TEXAS  
INSTRUMENTS**

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INPUTS			OUTPUT $\bar{Q}$
$\overline{OE}$	LE	D	
L	H	H	L
L	H	L	H
L	L	X	$\bar{Q}_0$
H	X	X	Z

Logic diagram of a 1D latch. The diagram shows a central block labeled 'C1' and '1D'. The '1D' input is connected to a signal labeled '1D' (pin 3). The 'C1' input is connected to a signal labeled 'LE' (pin 11) through an inverter. The output of the latch is connected to a signal labeled '1Q' (pin 2) through an inverter. There are also two other inputs: 'OE' (pin 1) and '1D' (pin 3). The 'OE' input is connected to an inverter, and its output is connected to the output of the latch. The '1D' input is connected to the output of the latch. A bracket at the bottom indicates that the output is connected to seven other channels.

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## OCTAL TRANSPARENT D-TYPE LATCHES

### WITH 3-STATE OUTPUTS

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#### recommended operating conditions (see Note 3)

		SN54ABT533		SN74ABT533A		UNIT
		MIN	MAX	MIN	MAX	
V <sub>CC</sub>	Supply voltage	4.5	5.5	4.5	5.5	V
V <sub>IH</sub>	High-level input voltage	2		2		V
V <sub>IL</sub>	Low-level input voltage		0.8		0.8	V
V <sub>I</sub>	Input voltage	0	V <sub>CC</sub>	0	V <sub>CC</sub>	V
I <sub>OH</sub>	High-level output current		–24		–32	mA
I <sub>OL</sub>	Low-level output current		48		64	mA
Δt/Δv	Input transition rise or fall rate		10		10	ns/V
T <sub>A</sub>	Operating free-air temperature	–55	125	–40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.

#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		T <sub>A</sub> = 25°C			SN54ABT533		SN74ABT533A		UNIT
			MIN	TYP†	MAX	MIN	MAX	MIN	MAX	
V <sub>IK</sub>	V <sub>CC</sub> = 4.5 V, I <sub>I</sub> = −18 mA		−1.2			−1.2		−1.2		V
V <sub>OH</sub>	V <sub>CC</sub> = 4.5 V, I <sub>OH</sub> = −3 mA		2.5			2.5		2.5		V
	V <sub>CC</sub> = 5 V, I <sub>OH</sub> = −3 mA		3			3		3		
	V <sub>CC</sub> = 4.5 V	I <sub>OH</sub> = −24 mA	2			2				
		I <sub>OH</sub> = −32 mA	2*					2		
V <sub>OL</sub>	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 48 mA	0.55			0.55				V
		I <sub>OL</sub> = 64 mA	0.55*					0.55		
V <sub>hys</sub>			100							mV
I <sub>I</sub>	V <sub>CC</sub> = 5.5 V, V <sub>I</sub> = V <sub>CC</sub> or GND		±1			±1		±1		μA
I <sub>OZH</sub>	V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 2.7 V		10			10		10		μA
I <sub>OZL</sub>	V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 0.5 V		−10			−10		−10		μA
I <sub>off</sub>	V <sub>CC</sub> = 0, V <sub>I</sub> or V <sub>O</sub> ≤ 4.5 V		±150					±150		μA
I <sub>CEX</sub>	V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 5.5 V	Outputs high	50			50		50		μA
I <sub>O‡</sub>	V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 2.5 V		−50	−140	−180	−50	−180	−50	−180	mA
I <sub>CC</sub>	V <sub>CC</sub> = 5.5 V, I <sub>O</sub> = 0, V <sub>I</sub> = V <sub>CC</sub> or GND		Outputs high		1	250	250		250	μA
			Outputs low		24	30	30		30	mA
			Outputs disabled		0.5	250	250		250	μA
ΔI <sub>CC</sub> §	V <sub>CC</sub> = 5.5 V, One input at 3.4 V, Other inputs at V <sub>CC</sub> or GND		Outputs high		1.5		1.5		1.5	mA
			Outputs low		1.5		1.5		1.5	
			Outputs disabled		1.5		1.5		1.5	
C <sub>i</sub>	V <sub>I</sub> = 2.5 V or 0.5 V		3.5							pF
C <sub>O</sub>	V <sub>O</sub> = 2.5 V or 0.5 V		6.5							pF

\* On products compliant to MIL-PRF-38535, this parameter does not apply.

† All typical values are at V<sub>CC</sub> = 5 V.

‡ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

§ This is the increase in supply current for each input that is at the specified TTL voltage level rather than V<sub>CC</sub> or GND.



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## OCTAL TRANSPARENT D-TYPE LATCHES

### WITH 3-STATE OUTPUTS

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timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

			SN54ABT533		UNIT
			$V_{CC} = 5\text{ V}$ , $T_A = 25^{\circ}\text{C}$		
			MIN	MAX	
$t_w$	Pulse duration, LE high		3.3	3.3	ns
$t_{su}$	Setup time, data before LE↓	High or low	2.1	2.1	ns
$t_h$	Hold time, data after LE↓	High or low	1.5	1.5	ns

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

			SN74ABT533A		UNIT
			$V_{CC} = 5\text{ V},$ $T_A = 25^{\circ}\text{C}$		
			MIN	MAX	
$t_w$	Pulse duration, LE high		3.3	3.3	ns
$t_{su}$	Setup time, data before LE↓	High or low	2.1	2.1	ns
$t_h$	Hold time, data after LE↓	High or low	2.1	2.1	ns

switching characteristics over recommended ranges of supply voltage and operating free-air temperature,  $C_L = 50\text{ pF}$  (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	SN54ABT533				UNIT	
			V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C			MIN		MAX
			MIN	TYP	MAX			
t <sub>PLH</sub>	D	$\overline{Q}$	1.9	4.2	5.4	1.9	6.7	ns
t <sub>PHL</sub>			3.1	4.9	6.3	3.1	6.9	
t <sub>PLH</sub>	LE	$\overline{Q}$	2.7	4.9	6.2	2.7	7.6	ns
t <sub>PHL</sub>			3.5	5.4	6.8	3.5	7.5	
t <sub>PZH</sub>	$\overline{OE}$	$\overline{Q}$	1.6	3.7	4.8	1.6	5.8	ns
t <sub>PZL</sub>			2.4	4.2	6.2	2.4	6.9	
t <sub>PHZ</sub>	$\overline{OE}$	$\overline{Q}$	2.8	5.1	6.2	2.8	7.2	ns
t <sub>PLZ</sub>			2	4.1	6	2	6.9	

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switching characteristics over recommended ranges of supply voltage and operating free-air temperature,  $C_L = 50$  pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	SN74ABT533A					UNIT
			V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C			MIN	MAX	
			MIN	TYP	MAX			
t <sub>PLH</sub>	D	$\overline{Q}$	1.7	4.2	5.4	1.7	6.4	ns
t <sub>PHL</sub>			2.6	4.9	6.3	2.6	6.6	
t <sub>PLH</sub>	LE	$\overline{Q}$	2.7	4.9	6.2	2.7	7.3	ns
t <sub>PHL</sub>			3.5	5.4	6.8	3.5	7.3	
t <sub>PZH</sub>	$\overline{OE}$	$\overline{Q}$	1.6	3.7	4.8	1.6	5.7	ns
t <sub>PZL</sub>			2.4	4.2	6.2	2.4	6.7	
t <sub>PHZ</sub>	$\overline{OE}$	$\overline{Q}$	1.6	5.1	6.2	1.6	6.9	ns
t <sub>PLZ</sub>			2	4.1	6	2	6.5	

# SN54ABT533, SN74ABT533A

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### WITH 3-STATE OUTPUTS

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#### PARAMETER MEASUREMENT INFORMATION



LOAD CIRCUIT

TEST	S1
$t_{PLH}/t_{PHL}$	Open
$t_{PLZ}/t_{PZL}$	7 V
$t_{PHZ}/t_{PZH}$	Open



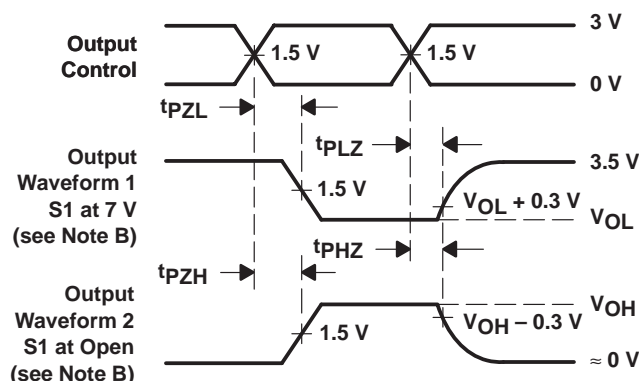
VOLTAGE WAVEFORMS  
PULSE DURATION



VOLTAGE WAVEFORMS  
SETUP AND HOLD TIMES



VOLTAGE WAVEFORMS  
PROPAGATION DELAY TIMES  
INVERTING AND NONINVERTING OUTPUTS



VOLTAGE WAVEFORMS  
ENABLE AND DISABLE TIMES  
LOW- AND HIGH-LEVEL ENABLING

- NOTES:
- A.  $C_L$  includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 10 \text{ MHz}$ ,  $Z_O = 50 \Omega$ ,  $t_r \leq 2.5 \text{ ns}$ ,  $t_f \leq 2.5 \text{ ns}$ .
  - D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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